

Sweepmeter[™] for Ultra-Precise Wavelength Calibration

High accuracy wavelength determination for fast swept tunable lasers

SPECIFICATIONS

The PPC Sweepmeter [™] provides an accurate,
high-resolution, NIST traceable calibration of
wavelength for sweeping tunable lasers. The
Sweepmeter [™] is ideal for testing optical compo-
nents such as MUX/DEMUX, dispersion compen-
sators, and etalons; remote sensing with fiber
Bragg grating spectroscopy; gas spectroscopy;
and wavelength linearization of laser systems.

The Sweepmeter's proprietary measurement system enables data acquisition synchronized with accurate, real-time wavelength calibration, requires minimum communication bandwidth, and integrates easily into swept wavelength measurement systems.

<i>Wavelength Resolution</i> User Programmable, 0.4 to 48 pm/sample (0.050-6 GHz/sample)	Clock 270 lase
<i>Wavelength Accuracy</i> <1 pm rms	<i>Comn</i> Con
<i>Wavelength Repeatability</i> <0.2 pm rms	PXI Add
NIST-Traceable Calibration HCN gas cell calibrates every scan	Softw SCF NI-V Lab
<i>Wavelength Scan Speed</i> 1-100 nm/s	
<i>Operating Wavelength Range</i> 1500-1650 ¹ nm	Electr cPC Ber (AC Packa cPC Ben 7" >
<i>Optical Input Power Range</i> -25 to 0 dBm	
<i>Input Fiber Adapter</i> FC/APC, narrow-key	
Polarization Dependence None	Additi Mo
<i>Trigger Input</i> Two user-configurable triggers; BNC connectors; TTL levels	
<i>Clock Output</i> Real-time, equal-optical-frequency clock for triggering data acquisition; BNC connector; TTL levels.	

Output Frequency 0 ksamples/sec maximum (depends on er scan rate and resolution)

munication mpactPCI/PXI, GPIB and RS-232 (bench top)

ditional user-configurable clock output d trigger inputs on PXI bus.

vare

PI command interface VISA instrument drivers for bView/LabWindows

rical Power

CI/PXI version: Powered from PXI Bus, < 3 W nch-top version: 6 - 12 VDC input, < 2 W C adapter included)

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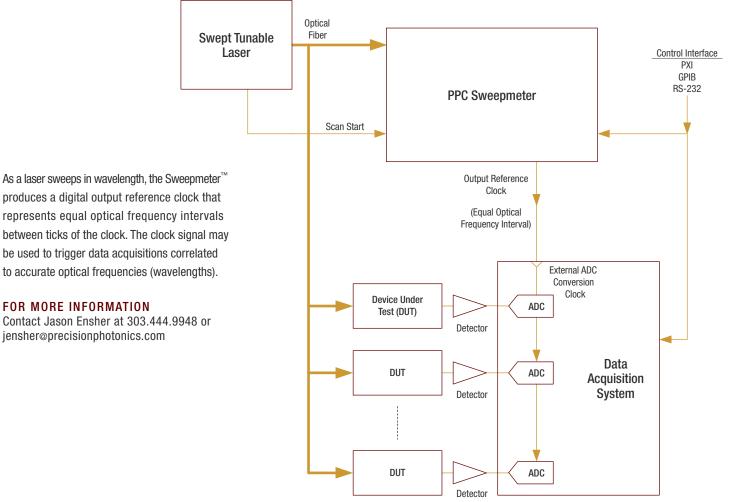
CI/PXI version: 3U x 8HP (2 slot wide) nch-top version: shielded aluminum case, x 6" x 3"

tional Features de-hop fault detection²

¹ Wavelength scan must overlap 20 nm in the range 1528-1563 nm.

² Accurate wavelength calibration requires mode-hop-free laser tuning.

Sweepmeter[™]Application: *Passive Device Characterization*



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